

# TM08H06S

## N+N-Channel Enhancement Mode Mosfet

### General Description

- Low  $R_{DS(ON)}$
- RoHS and Halogen-Free Compliant

### Applications

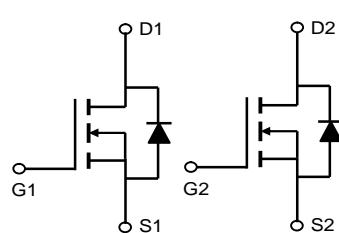
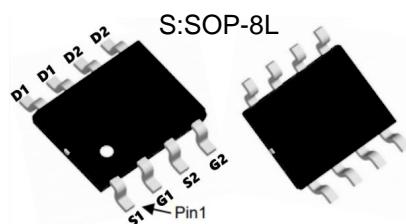
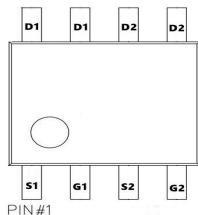
- Load switch
- PWM

### Product Summary

$V_{DS} = 60V$   $I_D = 8.0A$

$R_{DS(ON)} = 25m\Omega$ (typ.) @ $V_{GS}=10V$

100% UIS Tested  
100%  $R_g$  Tested



Marking: 08V06

### Absolute Maximum Ratings ( $T_A = 25^\circ C$ unless otherwise noted)

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	60	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D @ T_A=25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V^1$	8.0	A
$I_D @ T_A=70^\circ C$	Continuous Drain Current, $V_{GS} @ 10V^1$	5.5	A
$I_{DM}$	Pulsed Drain Current <sup>2</sup>	34	A
EAS	Single Pulse Avalanche Energy <sup>3</sup>	28	mJ
$I_{AS}$	Avalanche Current	10	A
$P_D @ T_A=25^\circ C$	Total Power Dissipation <sup>4</sup>	1.5	W
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C
T <sub>J</sub>	Operating Junction Temperature Range	-55 to 150	°C

### Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
R <sub>θJA</sub>	Thermal Resistance Junction-ambient <sup>1</sup>	---	80	°C/W
R <sub>θJC</sub>	Thermal Resistance Junction-Case <sup>1</sup>	---	25	°C/W

**TM08H06S**
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**Electrical Characteristics ( $T_J = 25^\circ\text{C}$ , unless otherwise noted)**

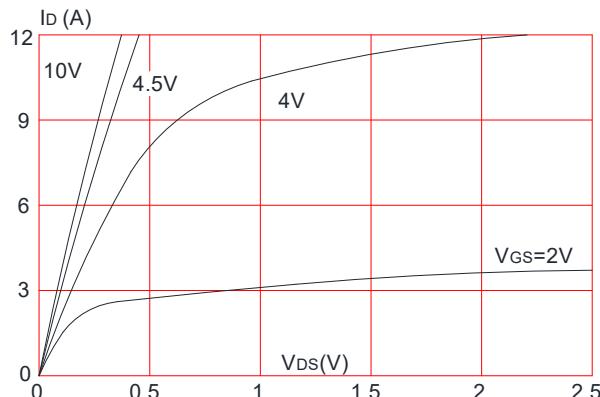
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{GS} = 0V, I_D = 250\mu\text{A}$	60	-	-	V
Gate-Body Leakage Current	$I_{GSS}$	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	$\pm 100$	nA
Zero Gate Voltage Drain Current  T <sub>J</sub> =25°C	$I_{DSS}$	$V_{DS} = 60V, V_{GS} = 0V$	-	-	1	$\mu\text{A}$
T <sub>J</sub> =100°C			-	-	100	
Gate-Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1.2	1.6	2.5	V
Drain-Source on-Resistance <sup>4</sup>	$R_{DS(\text{on})}$	$V_{GS} = 10V, I_D = 10\text{A}$	-	25	32	$\text{m}\Omega$
		$V_{GS} = 4.5V, I_D = 5\text{A}$	-	33	40	
Forward Transconductance <sup>4</sup>	$g_{fs}$	$V_{DS} = 5V, I_D = 10\text{A}$	-	15.5	-	S
<b>Dynamic Characteristics<sup>5</sup></b>						
Input Capacitance	$C_{iss}$	$V_{DS} = 30V, V_{GS} = 0V, f = 1\text{MHz}$	-	1055	-	$\text{pF}$
Output Capacitance	$C_{oss}$		-	60	-	
Reverse Transfer Capacitance	$C_{rss}$		-	49	-	
Gate Resistance	$R_G$	$f = 1\text{MHz}$	-	1.2	-	$\Omega$
<b>Switching Characteristics<sup>5</sup></b>						
Total Gate Charge	$Q_g$	$V_{GS} = 10V, V_{DD} = 30V, I_D = 10\text{A}$	-	22	-	$\text{nC}$
Gate-Source Charge	$Q_{gs}$		-	4.2	-	
Gate-Drain Charge	$Q_{gd}$		-	6.9	-	
Turn-on Delay Time	$t_{d(on)}$	$V_{GS} = 10V, V_{DD} = 30V, R_G = 3\Omega, I_D = 10\text{A}$	-	6.4	-	$\text{ns}$
Rise Time	$t_r$		-	15.3	-	
Turn-off Delay Time	$t_{d(off)}$		-	25	-	
Fall Time	$t_f$		-	7.6	-	
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F = 10\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$	-	26	-	$\text{ns}$
Body Diode Reverse Recovery Charge	$Q_{rr}$		-	45	-	$\text{nC}$
<b>Drain-Source Body Diode Characteristics</b>						
Diode Forward Voltage <sup>4</sup>	$V_{SD}$	$I_S = 10\text{A}, V_{GS} = 0V$	-	-	1.2	V
Continuous Source Current	$I_S$	-	-	-	8	A

Notes:

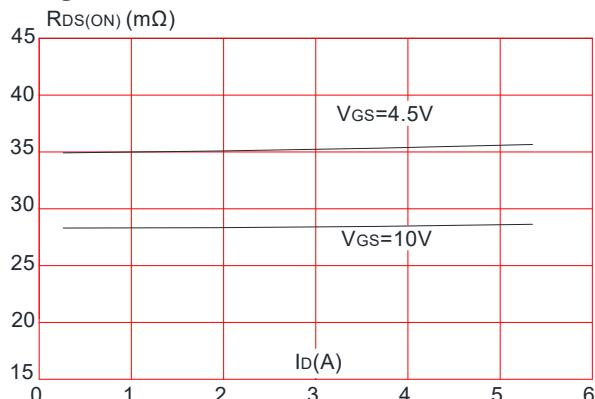
1. Repetitive rating, pulse width limited by junction temperature  $T_{J(\text{MAX})} = 150^\circ\text{C}$
2. The EAS data shows Max. rating . The test condition is  $V_{DD}=25V, V_{GS}=10V, L=0.4\text{mH}, I_{AS}=14\text{A}$
3. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper, The value in any given application depends on the user's specific board design.
4. The data tested by pulsed , pulse width  $\leq 300\mu\text{s}$  , duty cycle  $\leq 2\%$ .
5. This value is guaranteed by design hence it is not included in the production test.

## Typical Performance Characteristics

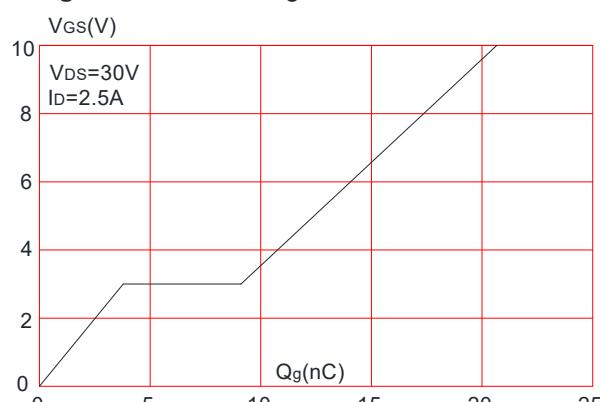
**Figure 1:** Output Characteristics



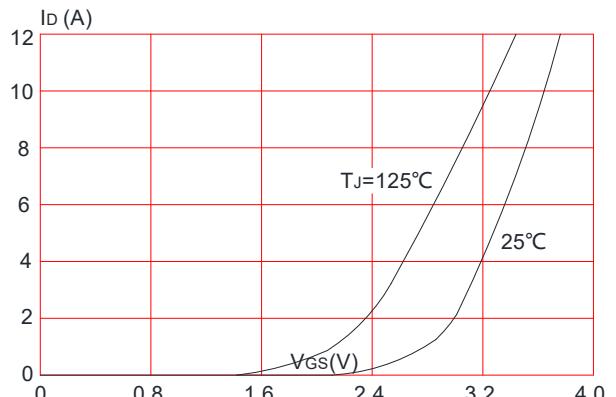
**Figure 3:** On-resistance vs. Drain Current



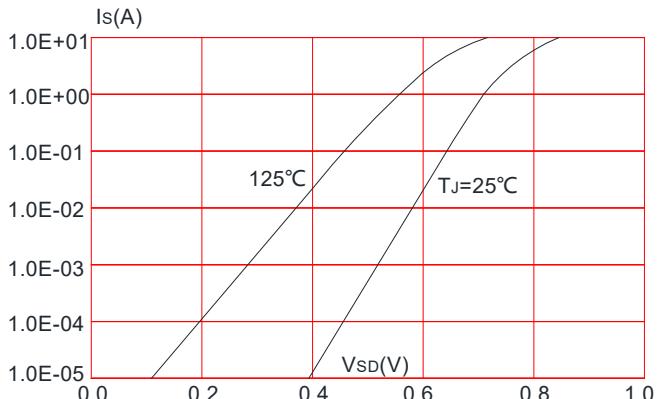
**Figure 5:** Gate Charge Characteristics



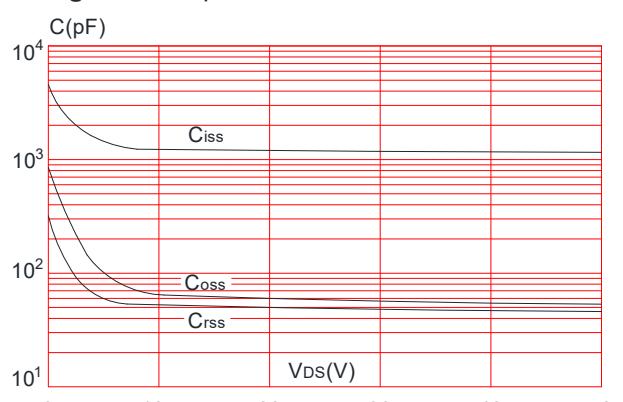
**Figure 2:** Typical Transfer Characteristics



**Figure 4:** Body Diode Characteristics



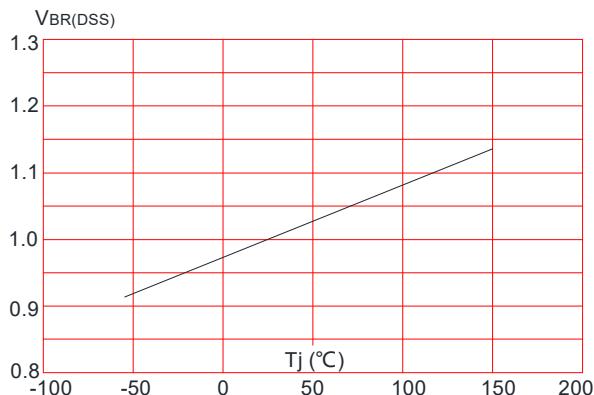
**Figure 6:** Capacitance Characteristics



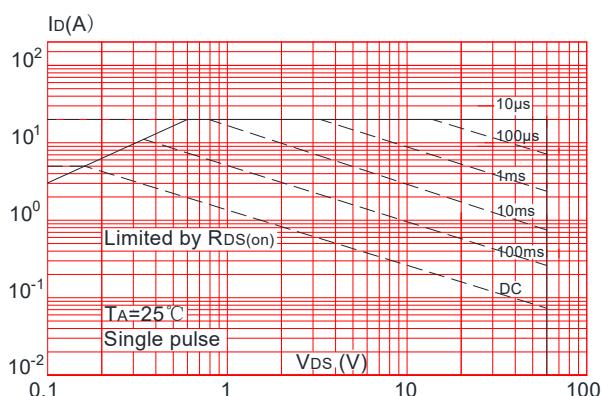
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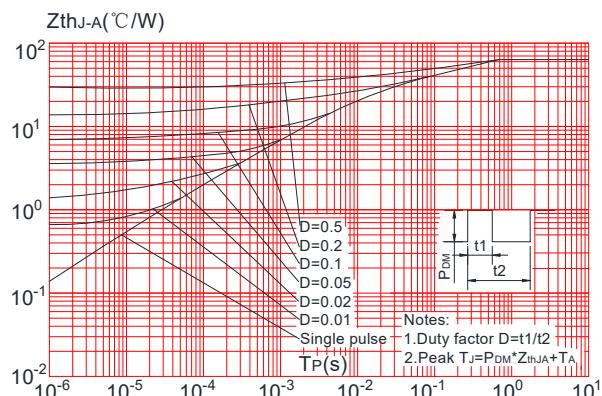
**Figure 7:** Normalized Breakdown Voltage vs. Junction Temperature



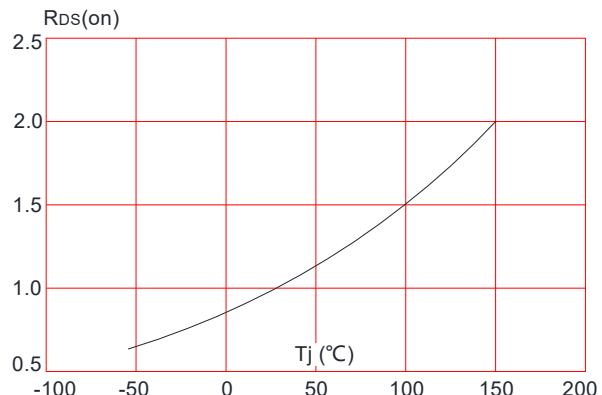
**Figure 9:** Maximum Safe Operating Area



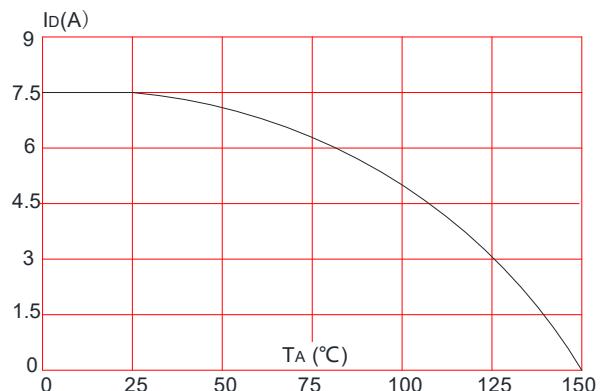
**Figure.11:** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



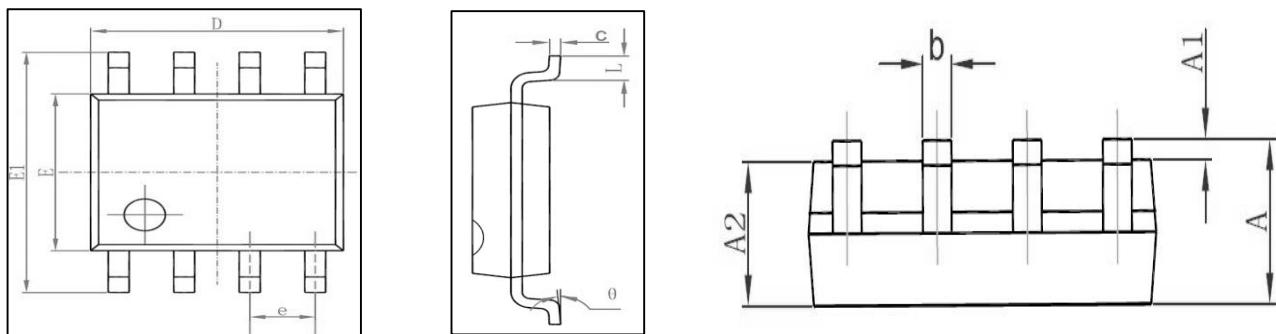
**Figure 8:** Normalized on Resistance vs. Junction Temperature



**Figure 10:** Maximum Continuous Drain Current vs. Ambient Temperature



## Package Mechanical Data:SOP-8L



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270 (BSC)		0.050 (BSC)	
L	0.400	1.270	0.016	0.050
$\theta$	0°	8°	0°	8°

